Student self-introduction -Inseok Yoon.

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Yoon Inseok.

SNU/RIKEN

1. Personal

- Born in Pohang, Korea and grown up in Seoul, Korea.
- Bachelor of physics, SNU (2007-2011)
 - Joined Reno experiment as summer school student.
- Graduate school of physics, SNU (2011-current)
 - Joined Kiyoshi's Lab (2011)
 - Took first shift at PHENIX on Run12
 - In earnest, I've worked on PHENIX since Run13.
- Hobby
 - Marine aquarium: feeding fish and corals.
 - Working around my town with my wife and dog.
 - Watching or playing baseball.

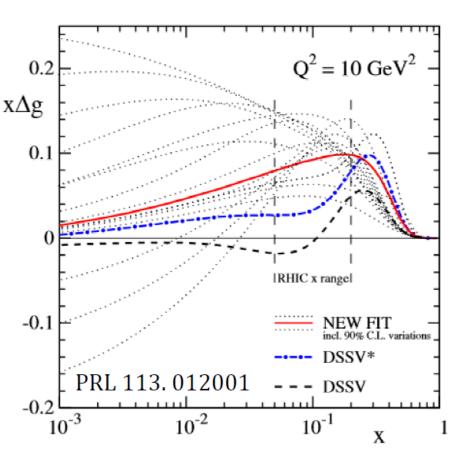




2. My works in PHENIX

- Mutr maintenance. (Recap.)
- ERT Expert since 2013.
 - ERT commissioning, and monitor and update ERT status.
- Run13 spin DB update
- Run13 Relative luminosity study.
 - Width, pileup and residual correction.

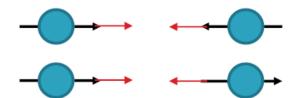
- Spin sum rule: $\frac{1}{2} = \int_0^1 dx \left[\frac{1}{2} \sum_q (\Delta q + \Delta \overline{q}) (x, \mu^2) + \Delta g(x, \mu^2) \right] + L$ DIS experiment: quark contribution is only 25~35%.
 - Gluon polarization, $\Delta G = \int_0^1 dx \Delta g(x)$
- PP collision provide access to Δg through gg and qg scattering.
- $A_{LL}^{\pi^0}$ measurements give access to Δg
- $A_{LL}^{\pi^0}$ at higher $\sqrt{s} = 510 \, \text{GeV}$ extends the sensitivity to Δg to lower Bjorken x.

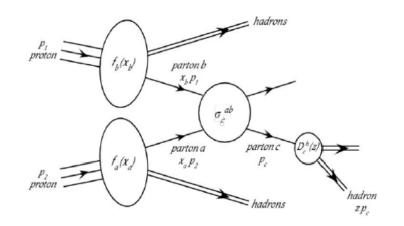


$$\bullet A_{LL}^{\pi^0} = \frac{1}{P_B P_Y} \frac{\sigma_{++}^{\pi^0} - \sigma_{+-}^{\pi^0}}{\sigma_{++}^{\pi^0} + \sigma_{+-}^{\pi^0}}$$

 $\sigma_{++}^{\pi^0}$: σ^{π^0} from same helicity proton collision.

 $\sigma_{+-}^{\pi^0}$: σ^{π^0} from opposite helicity proton collision.





$$\sigma^{f_a f_b \to f_c X}$$
: pQCD

$$D_{f_c}^{\pi^0}$$
: e^+e^- experiment

$$\bullet A_{LL}^{\pi^0} = \frac{\sigma^{\pi^0}_{++} - \sigma^{\pi^0}_{+-}}{\sigma^{\pi^0}_{++} + \sigma^{\pi^0}_{+-}} = \frac{\sum_{f_a, f_b, f_c} \Delta f_a \otimes \Delta f_b \otimes d\widehat{\sigma}^{f_a f_b \to f_c X} \otimes D_{f_c}^{\pi^0}}{\sum_{f_a, f_b, f_c} f_a \otimes f_b \otimes \widehat{\sigma}^{f_a f_b \to f_c X} \otimes D_{f_c}^{\pi^0}}$$

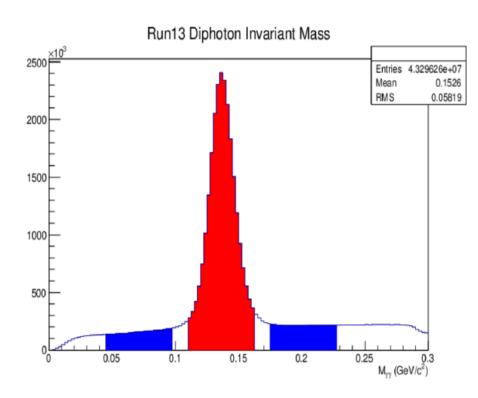
• Count yield of signal and side region.

•
$$A^{Peak(Side)}_{LL} = \frac{1}{P_B P_Y} \frac{\sigma_{++} - \sigma_{+-}}{\sigma_{++} + \sigma_{+-}}$$

$$= \frac{1}{P_B P_Y} \frac{\frac{N_{++}}{\varepsilon_{++} L_{++}} - \frac{N_{+-}}{\varepsilon_{+-} L_{+-}}}{\frac{N_{++}}{\varepsilon_{++} L_{++}} + \frac{N_{+-}}{\varepsilon_{+-} L_{+-}}}$$

$$= \frac{1}{P_B P_Y} \frac{N^{Peak(Side)}_{++} - RN^{Peak(Side)}_{+-}}{N^{Peak(Side)}_{++} + RN^{Peak(Side)}_{+-}}$$
where $R = \frac{L_{++}}{L_{+-}}$. (source of syst.)

•
$$A_{LL}^{\pi^0} = \frac{A_{LL}^{Peak} - rA_{LL}^{Side}}{1 - r}$$
,
r = background fraction.



Identifiable mass peak.
 Large stat.
 Various cuts to minimize uncert.

